

Notice of References Cited	Application/Control No. 10/066,545	Applicant(s)/Patent Under Reexamination TSIKOS ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,422,467	07-2002	Lucera et al.	235/462.23
*	C	US-6,411,199	06-2002	Geiszler et al.	340/10.1
*	D	US-6,318,637	11-2001	Stoner, Paul Douglas	235/472.01
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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